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# Automated Electrostatic Discharge Self-Audit System in Semiconductor Industry



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#### **ABSTRACT**

Electrostatic Discharge (ESD) is a well-known control process in semiconductor industries, military, medical industry, aerospace industry, oil and gas industry and so on. ESD means the collision between two elements with influence of humidity will create static charges. The static charge will be measured in voltage/inch and then compared with the sensitivity of the Electrostatic Discharge Sensitive (ESDS) items to avoid electronics malfunctions and latent damage to the items. Human Body Model (HBM) tests are done periodically based on the semiconductor industry and customer requirements. The new revision recommends the HBM test done on daily basis for the high control. Common control for HBM involve the footwear test and wrist strap test which done manually. The tighten control for daily test is not possible for manual method of testing, so the idea of converting to automatic testing system are designed and implemented. This design will able to do ESD HBM test daily before entering production floor and the same time adding value as monitoring system as well. The HBM Model test will emphasis hundred percent accuracy of employees testing their ESD attires and also improve the common manual system to an automated system. Implementation of this system will ensure product quality and also minimize the risk of ESD events occurring in semiconductor industry.

#### Keywords:

Electrostatic Discharge, Human Body Voltage, Audit System

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#### 1. Introduction

Electrostatic Discharge (ESD) control is a vital requirement in semiconductors industries and there are many activities are carried out many associations to identify the cause of ESD events on the Electrostatic Discharge Sensitivity (ESDS) items such as components, printed circuit board assembly (PCBA), inductors and so on. The common cause for the event is Human Body Model (HBM) effects which discussed by author [1-2] and the common control that in current implementation and approved based on the global ESD association are described by author [3-7].

Control HBM is the important element where controlled by using proper ESD protection attire such as ESD Shoe and ESD Wrist Strap which are commonly in use at many semiconductor industries. The daily audit system is required to maintain the functionality of these attires and manual way of self-audit is not suitable, so the automated system is introduced. The idea is to install the ESD test application inside the turnstile gate so the attires are tested every day.

The ESD control programs have played a vital role to avoid most of the ESD related failures; however statistics still show the failure cases happen in well controlled EPA production floor. From

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the statistic of ten years it shows that current ESD program are good but not good enough to identify and solve all ESD related problems that occurs in the electronic assembly production floor. The current ESD program is not fully able to prevent the ESD/EOS events, and the most common events that happen are related to HBM because the 50% of the failure recorded under ESD/EOS are affecting Integrated Circuits (IC) which commonly happens by human body charge induced. Controlling the HBM on semiconductor sites will bring much proven control for the site ESD programs by author [8-10], author [13-14] and author [12] describing the method to select and appropriate HBM control attires to control ESD events occurrences.

## 2. ESD Self-Audit System

The design of footplate for testing the ESD Shoe and design of input jack box for testing the wrist strap are illustrated using SketchUp and handover to appointed vendor for physical designing. The design of footplate meets the criteria to fulfill the weight and foot size of people and the input jack box are designed as per the wrist strap standard diameter application such as shown in Figure 1 and Figure 2.

The next process is the installation of these two items into the existing turnstile and also selecting the suitable software that can meet both security and ESD card scanning. The software selected for this process is Captain Green and tester is Megalin where both are Taiwan technology. The system need to combine with the turnstile gate so that only passed test are able to enter the production floor. The full installed turnstile system shown in Figure 3.

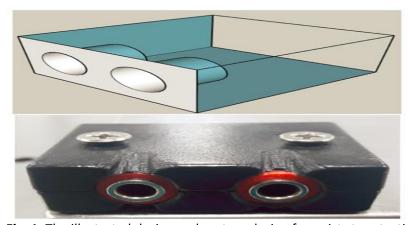


Fig. 1. The illustrated design and custom design for wrist strap testing

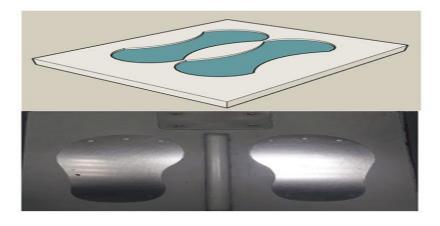


Fig. 2. The illustrated design and custom design for footwear testing



The ESD self-audit system installed turnstile will be connected to the Captain Green software which is the Megalin tester's custom designed software to capture the test data value. This process will need IT support and the organization approval to use their server and Ethernet access. This system will able to do HBM test for footwear and wrist strap at the same time.

#### 3. Results and Discussion

The system's hardware (footplate and wrist strap input jack) is design to meet all criteria of employees, especially the one physically challenged personal and also over weight employees. After the implementation the system on single turnstile gate, then the whole process is tested, validated and then analyzed, before the implementation for all existing turnstile gates. The advantages and disadvantages of the system studied and continuous improvement applied at those areas needed.

#### 3.1 Time saving

This system able to reduce the time of total sample of 1000 employees, at 40 percentage time reducing with 100 percentage of test done by all employees. This tackles two issues at the same point, ensure quality of test audit compliance are fulfilled and time to do this test are reduced. Figure 3.0 shows the statistical of auto and manual system comparison as weight taken as sample measurement.

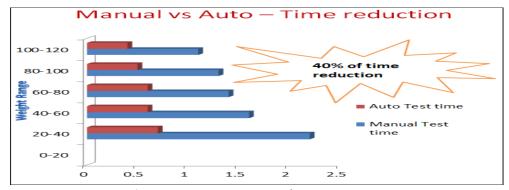


Fig. 3. Automatic vs manual test time

#### 3.2 The comparison between manual and automated system

The implementation of automated system not only able to reduce time and increase test percentage but also benefits more as shown in Table 1.

**Table 1**Comparison between automated and manual test system

SYSTEM	MANUAL ESD SELF-AUDIT SYSTEM	AUTOMATED ESD SELF-AUDIT SYSTEM	Conclusion	Advantage
Design	Able to bare only	Able to bare up to	More convenient	No need to
	max up to 120Kg	200Kg	for large size	custom new
	only		employees	design for certain
				employees



	Single plate planar	Double footwear planar	Both shoe test can be done together	Time saving
Test method	Using portable Resistance Meter, limit up to 2 decimal points	Using integrated system (Megalin) and software, test records up to 5 decimal points	Automated system capturing most persistence result	Persistence result help for better data analysis and error proofing
Employees	Not preferred	Easy and	Help employees to	Employees are
Feedback of	because many	comfortable for	save time and	happier and also
employees	limitation and not a	them as no skip	money ( no salary	learn about the
	compulsory test	process	deduction due to	importance of
	process for every		miss self-audit)	ESD.
	entry			
Management	Many process of	Impressed with	More business	Company's
Review	documentation and	automated system	prospect are on	reputation,
	monitoring for	that compromising	positive track	business and
	compromise the	customers		revenue
	customers regarding	requirement		increasing
	ESD control on site.			

The Table 1 is able clearly define how this system is able to meet the organization expectation towards the revenue development happened to be the ultimate goal for ESD controls in industry which stated by author [11] and author [15].

#### 4. Conclusions

This project is able to implement in semiconductor as this system meet the requirement of ANSI ESD S2020.2014 standard and the system able to detect the failure because it enters the production line. This will ensure the product are made is safe from ESDS events and confident during audits will be much higher and meets the global requirements as stated by ESDA.

### 5. Recommendation

The system are still addable to include another Electrostatic Control garments (smock) on its features so that in future this system can become one point audit system for all Human Body voltage control in Electrostatic controls in semiconductor industries.

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